

OPERATION MANUAL Model 800, The "MBA" Mask Aligner Standard/Motor-Z

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MBA- MODEL 800 MASK ALIGNER

Definitions of the following symbols and words are to be understood before working with this manual and the equipment. They are as follows:

"Caution" - Indicates a potentially hazardous situation which, if not avoided, may result in minor or moderate injury.



"Warning" - Indicates a potentially hazardous situation which, if not avoided, could result in death or serious injury.

"**Danger**" - Indicates an eminently hazardous situation which, if not avoided, will result in death or serious injury.

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SECTION 1: PURPOSE, SCOPE AND REVISION HISTORY

PURPOSE. To provide instructions on how to receive/ship, install, handle, use, trouble-shoot and maintain the 800MBA MASK ALIGNER hereinafter referred to as the EQUIPMENT.

SCOPE. To give the user of this document a complete understanding of the EQUIPMENT.

OBJECTIVE. To provide as much information as possible about the Equipment and to ensure that few, if any, questions will be raised relative to its operation and functionality over the short and long-term.

REVISION HISTORY.

Purpose	Rev Level	Release Date
New Release ECO 10238	А	1/21/09
Update for encoder functionality, ECO 10357	В	6/9/09
Change Company Logo & Text Colors, ECO 10826	С	6/30/11
Added buttons for mask and wafer separation and gap cal count ECO10893	D	9/26/11

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WARNING!



The high intensity energy produced by the included Light Source Subsystems employing mercury arc lamps can cause serious eye or skin damage. Personnel working with this equipment must wear eye protection with suitable filtration to block ultraviolet and infrared radiation, and avoid directly exposing skin for extended periods. OAI will not be responsible for injuries arising from incorrect or unprotected work with the Light Source Subsystem included with this Mask Aligner. The lightsource should not be adjusted or serviced by personnel lacking specific training. Before installing or operating this equipment, please read Section 3 of the included Light Source Manual, on safety. Due to the high voltage to start mercury arc lamps, the light source power supply starter circuit may create RF noise during the start up cycle. This might possibly have an effect on sensitive electronic equipment in the immediate area. Noise may also be created in the power supply AC input line during the start up cycle. To eliminate this potential problem, it is recommended to start the power supply and lamp before turning on any sensitive electronics in the immediate area. If this is not possible, it is also recommended to place the power supply and cabling at a distance from any sensitive electronics that are not adequately shielded.

Before installing or operating this equipment, be sure to read Section 4, SAFETY PRECAUTIONS

SECTION 2: INTRODUCTION

This manual is intended to provide instructions and recommendations for the proper use and maintenance of the EQUIPMENT.

2.1 GENERAL DESCRIPTION

The System consists of a System Console, Alignment Subsystem, and Exposure Subsystem. Movement of the align optics and light source are automated. All other functions are currently manual. Optional items are:

- Automated movement of the alignment stage for loading position and the alignment position.
- Automated leveling of the chuck
- Automated three-point leveling system where precision spacers are inserted between the chuck and the mask during the leveling process.

The EQUIPMENT is designed to align substrates to masks and to subsequently expose the substrate material using collimated UV light. This EQUIPMENT is intended for a variety of UV exposure related applications including Front Side Alignment & Exposure, and Back Side Alignment & Exposure. Exposure may be proximity or contact.

2.2 GETTING HELP

Assistance in answering questions relating to the operation of the EQUIPMENT can be obtained by calling OAI's customer support at 1 (408) 232-0600 between the hours of 8:00 A.M. and 5:00 P.M., Pacific Standard Time. Outside normal business hours, or at any other time, written questions may be Faxed to 1 (408) 433-9904 to the attention of the Optical Products Group Customer Support.

SECTION 3: RECEIVING AND UNPACKING THE EQUIPMENT

Normal receiving inspection procedures should be followed prior to unpacking the EQUIPMENT including the inspection of the Shock Warning label on the front of the crate.

Then, use a copy of these guidelines when ready to unpack and prepare the Equipment for installation. Be sure to follow all safety precautions used during the handling of packaging and related materials.

3.1 CHECK SHOCK WARNING LABEL

The color of the liquid capsule on the Shock Warning Label affixed to the side of the EQUIPMENT crate (shown in Figure 3-1) should be clear; if it's **red**, the shipment should be inspected for physical damage. If damage is found, reject the shipment per whatever process is used for unacceptable shipments.



Figure 3-1. Warning label, straps and clips on front of crated EQUIPMENT.

3.2 OPEN CRATE AND UNPACK EQUIPMENT



CAUTION! WEAR SAFETY GLASSES AND GLOVES AS PROTECTION FROM CUTS OR DAMAGE TO EYES WHEN CUTTING STRAPS AND REMOVING CLIPS!

1) If the shipment is accepted, cut and remove any straps securing the crate to the pallet (shown in Figure 3-1).

2) Remove any bolts along the bottom of the front of the crate.

3) If clips are used on the crate, use one hand loosely cupped over each clip to prevent damage to the eyes, pop off the clips around the edges of the front of the crate (shown in Figure 3-1). Use either the claw side of a hammer or a screwdriver to loosen same.

4) Remove the front of the crate and set it aside.

5) Remove any bolts from the bottom of the sides and back of the crate.

6) Lift the remaining three sides of the crate from the pallet and set it aside.

7) The pallet should contain several boxes. Remove the boxes and set them aside.



Note: Some of the boxes are very heavy. Use proper lifting techniques when handling this unit. The main unit weighs in excess of 600 pounds and should only be moved with a fork lift.

SECTION 4: SAFETY PRECAUTIONS

There are several major hazards to personnel:

- Ultraviolet light or non-ionizing radiation exposure
- Lamp explosion
- Electrical shock
- Ozone Poisoning
- UV Burn Hazard
- Heat Burn Hazard
- Possible mercury exposure from light source breakage

There is also a hazard to the equipment:

• Risk of damage to the light source during handling and shipping

4.1 HAZARDS TO PERSONNEL

Personnel using the UV LIGHT SOURCE should be aware of the hazards that stem from the UV LIGHT SOURCE. This section of the manual describes precautions that help avoid personal injury while using the equipment. Also, be sure to read **Section 10** entitled, SYSTEM INTERLOCKS.

4.1.1 UV BURN HAZARD



Prolonged exposure to diffused reflection from the output beam, illuminated surfaces in the beam, exposures of even a few seconds to the direct output beam or to the lamp itself, can cause ultraviolet skin burns or burns to the outer layers of the eye. Prolonged skin exposure can cause burns similar to severe sunburn.



WARNING!

WHEN IN THE VACINITY OF A LIGHT SOURCE WITH ITS COVER REMOVED, ALWAYS WEAR UV FILTERED GLASSES TO PROTECT EYES AND LIMIT EXPOSURE TIME TO UV RADIATION.

4.1.2 HEAT BURN HAZARD



When the UV lamp is on, the lamp heat sink and other metal pieces near the lamp get very hot. The heat sink and other metal pieces are located inside the lamp main housing to protect the operator from burns. The outside of the lamp main housing is safe to touch. If the main lamp housing needs to be opened for service and the lamp is on, the system that the light

source is mounted on should be powered down and locked out. Then the exhaust should be left on for 15 minutes to cool down the inside of the lamp housing before opening it for service.

4.1.3 HAZARDS DUE TO LAMP EXPLOSION



During operation, the light source is subjected to very high internal pressure; thus there is always the possibility of a lamp exploding due to internal strains or physical abuse. A lamp explosion can also be caused by contamination of the quartz envelope. Handle the lamps only by the metal end caps. **Do not touch** the quartz with bare hands. A lamp explosion inside the

closed light source housing can damage its internal components such as its reflector, light sensor, etc.

The lamp contains mercury. Any vapor released by an exploded lamp will be drawn out the UV LIGHT SOURCE exhaust and poses no danger to the operator; however, a minute amount of liquid mercury will be contained within the light source housing.

Follow the procedures below in the event of a lamp explosion:

- 1) Clear the area of personnel.
- 2) Notify the tool owner that mercury is in the facility exhaust.

3) Ensure that the UV LIGHT SOURCE exhaust system is working. Give it thirty minutes of run time to clear out the vapors and for the light source housing to cool to room temperature.



4) If the exhaust system is **NOT** working, put a full face respirator on prior to opening the light's containment area.



5) Put an extra pair of gloves on over the existing pair.

6) Using an "ear syringe", clean out the remaining liquid mercury.

7) Clean up broken glass and debris using a vacuum with a disposable filter attachment.

8) Wipe down the inside of the light source housing using alcohol and cleanroom wipes (or equivalent).

9) After clean-up, dispose of the "ear syringe", wipes, vacuum filter and outer pair of gloves in a container marked as mercury contaminated waste.

4.1.4 HAZARDS DUE TO ELECTRICAL SHOCK



Before changing the lamp, working on the light source, or performing any system maintenance requiring access to AC electrical power, turn off the power at the FACILITY AC POWER circuit breaker. After the power has been turned off, verify that the output voltage is zero.

4.1.5 HAZARDS DUE TO OZONE

Do not operate the system without proper room ventilation as some Deep UV lamps produce significant levels of ozone.

4.1.6 HAZARDS DUE TO MERCURY EXPOSURE FROM LIGHT SOURCE BREAKAGE

During operation, the light source is subjected to 20 to 30 atmospheres of pressure so the possibility exists of a lamp exploding due to internal strains or physical abuse. A lamp explosion inside the closed light source housing can damage its internal components such as the reflector, light sensor, etc.

The lamp contains mercury. Any vapor released by an exploded lamp will be drawn out the UV LIGHT SOURCE exhaust and poses no danger to the operator. However, a minute amount of liquid mercury will be contained within the light source housing.

Follow the procedures below in the event of a lamp breakage:

- 1) Clear the area of personnel.
- 2) Notify the tool owner that mercury is in the facility exhaust.

3) Ensure that the UV LIGHT SOURCE exhaust system is working, then give it thirty minutes of run time to clear out the vapors and for the light source housing to cool to room temperature.



4) If the exhaust system is **NOT** working, put a full face respirator on prior to opening the light's containment area.

5) Put an extra pair of gloves on over the existing pair.

6) Using an "ear syringe", clean out the remaining liquid mercury.

7) Clean up broken glass and debris using a vacuum with a disposable filter attachment.

8) Wipe down the inside of the light source housing using alcohol and cleanroom wipes (or equivalent).

9) After clean-up, dispose of the "ear syringe", wipes, vacuum filter and outer pair of gloves in a container marked as mercury contaminated waste.

SECTION 5: ITEMS SUPPLIED BY THE FACILITY

- Electrical Power: 120V, 1P, 60Hz, 20A
- CDA: 60 PSI
- N2: 15PSI
- VACUUM: 25in Hg
- Exhaust: For Exhaust requirements, see for the LIGHT SOURCE, See Section 12 System Specifications and Drawings.

SECTION 6: SYSTEM SETUP

6.1 PLACEMENT



CAUTION: The Mask Aligner should be moved using a forklift. The UV Power supply is also quite heavy and should be lifted by at least two (2) people. Place the Mask Aligner System in a suitable location with adequate clearance (36-inches front to back and 30-

inches shoulder clearance) in front of all electrical enclosures or where electrical work is to be performed. The System weighs approximately 700 pounds and should be placed on a table suitable for this weight.

6.2 LIGHT SOURCE

Remove the access panels from the the UV Light Source. These panels are held in place by panel mounting screws. After removing the cover plates, remove all of the packing material from inside the light source.



USE GLOVES to avoid damaging the coating on any reflective surfaces



Figure 6-1. Removable Light Source Panels

Refer to the Light Source manual for further setup procedures of the Light Source

6.3 SYSTEM CONSOLE.

Unpack any wrapping and remove any foam protective pieces that may be present.



Figure 6-2 Wrapping and packing materials

There are two shipping brackets on the back of the Mask Aligner that are used to prevent the Light Source/Alignment Optics Transport Assembly from moving during shipment. (Remove these).



Figure 6-3. Light Source/Alignment Optics Transport Assembly Shipping Brackets

The Alignment Optics X/Y mount stage is secured with pins that are screwed into the plates. (Figure 6-4). Do not move the stage until these pins have been placed back in the positions indicated in the next step.



Figure 6-4. Pins securing the Optics Mount Stage X/Y

Place one pin into one of the 3 holes at <u>each end of each</u> axis. (Figure 6-5) These pins are used as stop pins to prevent you from moving the optics beyond permissible travel limits and damaging the bearings. Any one of the holes on each end of each axis is permissible.



Figure 6-5. Holes to mount limit pins in.

A tie wrap is used to secure the Alignment Stage against movement. (Figure 6-6) It is difficult to see, however it is located at the back of the Alignment Stage. Remove this plastic tie wrap.



Figure 6-6. Alignment stage tie wrap.

6.4 CABLE CONNECTIONS.

6.4.1 Electrical

All cables are keyed to prevent errors in connections. Find the corresponding receptacles on the back of the Aligner & Power supply and plug in. Plug the power into the AC power strip and plug the AC power strip into the wall.



Figure 6-7. Electrical Cables.

6.4.2 Pneumatic

Connect the CDA, Vacuum, and N2 lines to the inlets at the back of the Mask Aligner.



Figure 6-8. Pneumatic Connections

SECTION 7: SYSTEM OPERATION

7.1 THEORY OF OPERATION

The 800MBA Mask Aligners will perform top side alignment in the normal manner. This is done by placing the substrate underneath the mask and aligning the substrate target to the mask target. Backside alignment is performed differently. First, the mask targets are positioned on the monitor and then crosshairs generated by a special Digital Video Pattern Generator (DVPG) are aligned to the mask targets. The wafer is then placed on the Chuck and the wafer is moved into position underneath the mask. The targets on the backside of the wafer are then aligned to the crosshairs on the monitor.



Figure 7-1 Digital Video Pattern Generator

7.2 DIGITAL VIDEO PATTERN GENERATOR (DVPG)

7.2.1 Description

There are two DVPG units of the mask aligner system. Each unit integrates one topside and one bottom side camera. The DVPG is a fully integrated camera switcher, split screen and adjustable digital video radical generator that allows simultaneous feeding of two cameras on a video or computer monitor. The DVPG creates adjustable reticles on each live video image independently. The DVPG creates six different reticle patterns (single crosshair, fixed in center single crosshair, dual crosshair, box, single crosshair with two sizable circles and no reticles). The created reticles can be set to two different line types (solid and dashed). The lines can be black or white. For normal operation a single crosshair is used.

7.2.2 Changing From Lockout (Hold) Mode

Upon initial start up, the DVPG is defaulted to the "HOLD" or lockout mode. This is indicated on the monitor in the upper left corner. When the "HOLD" is present, all keyboard functions are locked out. To remove the unit from the lockout mode, press and hold the "LOCK" button until the indicator in the top left corner of the monitor change from "HOLD" to "1". Keyboard function is now restored to the unit.

7.2.3 Setting The Reticle Type

The unit has six choices of reticle types to be displayed for each camera. Each time the "MODE" button (located on the top left of each individual camera control) is pressed, you change to a new type of reticle. Repeated pressing allows the user to toggle through the six reticle types. The six reticle types are as follows:

Single Crosshair Dual Crosshair Box Crosshair with Two Sizable Centered Circles Fixed in the Center Single Crosshair No Reticles

7.2.4 Setting The Reticle Line Style

There are two choices of line styles to be displayed (solid and dashed). The Line Style is selected by pressing the "SOLID/DASH" button for each desired camera (located on the top right of each individual camera control).

7.2.5 Reticle Movement

<u>LINES</u> – Pressing the arrow buttons on the keyboard in the desired direction will relocate the displayed reticle. The buttons can be pressed a single time to the move the reticle a small amount or pressed and held to move the reticle a large distance rapidly. Use the up and down buttons to move horizontal lines.

** Use the left and right buttons to move vertical lines.

<u>CIRCLES</u> - The first circle is sized using the up and down buttons. The second circle is sized using the left and right buttons.

7.2.6 Selecting The Camera

There is one DVPG for control of the left cameras and one DVPG for control of the right to cameras.

- To select the topside camera, press the "1 Only" button on the appropriate DVPG unit.
- To select the bottom side camera, press the "2 Only" but then on the appropriate DVPG unit.

7.3 TOP SIDE ALIGNMENT OPTICS POSITIONING



Figure 7-2 Positioning Controls for Top Side Alignment Optics

7.3.1 X/Y Positioning

The alignment optics may be moved in the X or Y axis by using the joystick handle. The entire surface of the wafer and chuck can be viewed by moving the alignment optics using this joystick. Both alignment optics move at the same time.

7.3.2 Separation Of Cameras

The Cameras may be moved in the X-axis independently. This is done by loosening the lock screw for the associated camera and sliding the camera left or right. After the camera is positioned properly, the lock screw is tightened to prevent further movement of the camera.

7.3.3 Theta Adjustment Of The Cameras

Theta adjustment of the cameras eliminates the need for any Theta adjustment of the mask. The Theta adjustment is performed by turning a micrometer. The micrometer is located close to the camera separation lock screws.



Figure 7-3 Top Side Camera Theta Adjustment Control

7.4 CAMERA ILLUMINATION CONTROLS

The controls for camera illumination are located at the left front of the mask aligner. There is a toggle switch for selecting either the top or the bottom side cameras. There are two control levers. One controls the illumination for the left camera and the other controls elimination for the right camera.



Figure 7-4 camera elimination controls

7.5 BOTTOM SIDE ALIGNMENT OPTICS POSITIONING

Each of the bottom side cameras is independently controllable in the X, Y, and Z- axis. Differential micrometers are used. The locations of these micrometers are shown in the picture below. The picture shown is the right alignment optics. The bottom left alignment optics are similar.



Figure 7-5 Bottom Side Alignment Optics Positioning Controls

7.6 ALIGNMENT STAGE AND WAFER CHUCK POSITIONING

7.6.1 Alignment Stage

The alignment stage is manually pulled out for the loading of the wafer onto the chuck. It is manually pushed in for alignment and exposure. An optional auto positioning feature is available. The picture below shows the alignment stage in the out position.



Figure 7-6 Online Bin Stage in the out Position

7.7 WAFER CHUCK X, Y, THETA, AND Z-AXIS POSITIONING CONTROLS

7.7.1 Standard System

The controls for the positioning of the wafer chuck on a standard system are shown in the picture below. The button on the front of the alignment stage is pressed when moving the chuck up into position against the mask during a leveling process. Pressing the button floats the chuck so it will easily level to the mask. Turning the z-axis knob until the clutch slips (indicated by a vibration felt through the z-axis knob) will ensure that the substrate is planar to the mask. The substrate should be moved away from the mask before any x,y, or theta motion of the chuck is initiated.



Figure 7-7 Wafer Chuck Positioning Controls for Standard System

7.7.2 Gap Setting and Calibration (Auto-Level option)

In the auto-z system configuration, once the "level" button is pressed on the LCD, the chuck will move up automatically to planarize the substrate surface with the mask. It will then automatically move to the alignment gap. This gap is set in the Additional Settings window of the Process Settings screen (see figure 7-18a). In practice, there may be as much as 100um of overdrive as the chuck forces up the mask before the z-axis clutch slips. This overdrive will cause the actual gap to be smaller than the gap that is entered into the process window. For most applications where the gap is for alignment purposes, a quick trial and error adjustment of the gap setting will ensure that the substrate is clear of the mask after planarization is accomplished.

The simplest way to calibrate the gap between the wafer and mask is to determine when the mask and wafer are at a zero-gap condition, and then press the ZERO GAP button. When the ZERO GAP button is pressed, the gap readout will automatically read 0 microns, and the GAP CALIBRATION COUNT will display the number of encoder counts the chuck z-axis has moved down from the position it was at after completing the planarization portion of the leveling routine. To determine if the wafer and mask are in a zero-gap condition:

- 1) Load a wafer on the chuck, enable substrate vac, and level the wafer against the mask.
- After the leveling routine is complete, the wafer is at the user determined alignment gap. Press the CAL GAP button bring up the screen shown in Figure 7-7a.
- 3) Set the jog size to 4um and jog up, bringing the wafer and chuck into contact with each other. As the mask and wafer come into contact with each other and then are pressed harder and harder together, a slight shift will be noticed on the monitor between the wafer features and the mask features. This is undesirable as it indicates that too much force is present between the mask and wafer. Jog the wafer back down and back up to the highest z-location that doesn't exhibit this lateral shifting. Note: The jog size can be set to any value between 3 and 3000 um.
- 4) Press the ZERO GAP button to train the aligner gap calibration routine. The aligner now knows how far to move down after planarization to achieve this "soft-contact" position.
- 5) To further refine this position, exit the Cal Gap screen and in the Run Screen, press the UNLOAD button.
- 6) After the chuck is down and at its home position, press the LEVEL button to planarize the wafer and mask.
- 7) After the Leveling routine completes, press the CONTACT button to move the wafer into contact with the mask. Now press the HARD CONTACT button several times, turning on and off the hard contact process feature. There will likely be a very small shift in the wafer location when the hard contact is enabled due to the force of the nitrogen pushing on the back side of the wafer. However, if the wafer is in contact with the mask, the wafer will return to its previous position on the monitor when hard contact is disabled.
- 8) If it is determined that the wafer is not touching the mask in soft contact (by noticing that the wafer "walks" across the monitor when hard contact is cycled on and off) then the gap calibration must be adjusted.
- 9) To adjust the gap calibration, go back into the Gap Cal screen shown in figure 7-7a and adjust the GAP CALIBRATION COUNT by pressing on this button and changing the value. To bring the wafer closer to the mask, adjust the count down by 1 count.
- 10)Repeat steps 5 through 8 as needed. When the proper gap calibration count has been determined, record the number for future use. This number should be appropriate for the current wafer size and mask size and thickness. (note that wafer thickness will have no bearing on the gap

calibration count, but mask thickness will due to its effect on mask deflection).

Note that for different wafer and mask size/thickness combinations, the gap calibration count determined from the above procedure for one combination will serve as a good starting point for another combination as the gap calibration count is likely to be adjusted by only 1 or 2 counts from combination to combination.

To implement a previous calibration for a given mask size/thickness and wafer size combination, the user only needs to place the wafer on the chuck, enable substrate vac, and level the chuck. Then go to the Gap Cal screen and enter the desired Gap Calibration Count. As long as the clutch current is maintained, the gap will be calibrated.



7.8 N2 PURGE & CONTACT VACUUM, AND HARD CONTACT ADJUSTMENTS



Figure 7-8 Contact Vacuum & N2 Pneumatic Controls

When exposing a substrate, the operator has the option of utilizing a gap exposure, a soft contact exposure, a hard contact exposure, or a vacuum contact exposure. During and after a gap exposure, the flow of nitrogen across the surface of the substrate is regulated using the N2 Purge Flow regulator. The N2 Hard Contact flow regulator controls the flow of nitrogen underneath the substrate such that the substrate is forced hard against the mask. The vacuum achieved during a contact vacuum exposure is regulated by the combination of the Contact Vac Adjustment valve and the N2 Purge Flow valve.

7.9 LCD TOUCH SCREEN SYSTEM CONTROLLER

The LCD touch screen controller is located at the front right side of the mask aligner. This unit provides a method to control the mask aligner exposure set up, vacuum solenoids, and various expose sequences. This screen is the primary interface to the functions of the mask aligner.

Through the use of this screen you may:

- Turn the mask vacuum on and off
- Set the exposure time
- Set the exposure mode (hard, vacuum, proximity)
- Level the chuck on systems with the auto level option
- Display the alignment gap on systems with the encoder option

7.9.1 Main Menu Screen

7.9.1.1 Main Menu for Standard Systems - This screen is used to select all of the sub screens wherein settings or controls are located.



Figure 7-9 Main Menu for Standard Systems





7.9.2 Start Up and Leveling Screen (Only on Systems with Auto Level)

This screen is the screen that controls the initiation of the system and the leveling of the chuck. This screen is used to:

- Return to the Main Menu
- Display the Processing Mode
- Display the Exposure Time
- Turn the Substrate Vacuum on and off
- Initiate or Level (as shown in the first figure below this button is labeled "INITIATE" and is used to start the initiation process when the system is first turned on. As shown in the second figure below this button is labeled "LEVEL" and is used to start the auto leveling of the chuck.)
- Go to the alignment gap without first leveling the substrate to the mask. The first wafer processed when the system is initiated must be leveled. This feature requires that the z-encoder option be installed.



• Set the motor speed during the leveling process. Speed range is 325 to 3150.

Figure 7-11 Startup Screen for Systems with Auto Level (GOTO GAP WITHOUT LEVEL REQUIRES Z-ENCODER OPTION)

MA IN MENU	LEVEL MOTOR SPEED	PROCESS Mode : Front Side Exposure
SUB- STRATE VACUUM		TIME O.O SECONDS
	GOTO GAP WITHOUT LEVEL	O CYCLES
LEVEL RUNN ING		OFF TIME -O.O SECONDS

Figure 7-12 Level Screen for Systems with Auto Level (GOTO GAP WITHOUT LEVEL REQUIRES Z-ENCODER OPTION)

7.9.3 Running Screen

- **7.9.3.1 Running Screen for Standard Systems** This is the screen that controls the actual running of the mask aligner during alignment and exposure. This screen is used to:
- Return to the Main Menu
- Display the Processing Mode
- Display the Exposure Time
- Turn the Substrate Vacuum on and off
- Turn the Hard Contact Mode on and off
- Turn the Contact Vacuum on and off
- Cycle (moves the transport stage to position the optics over the mask & wafer, or position the light source over the mask & wafer and perform an exposure)



Figure 7-13 Running Screen for Standard Systems

- **7.9.3.2** Running Screen for Systems with Auto Level -This is the screen that controls the actual running of the mask aligner during alignment and exposure. This screen is used to:
- Return to the Main Menu
- Unload the Substrate before Exposing
- Display the Exposure Time
- Move the chuck up and down between the gap position and the contact position. As this is done, the display on the corresponding button on the LCD panel will change accordingly. In the figure shown the button is currently set to "move to contact position".
- Turn the Hard Contact Mode on and off
- Turn the Contact Vacuum on and off
- Cycle (moves the transport stage to position the optics over the mask & wafer, or position the light source over the mask & wafer and perform an exposure)
- Additionally, in the case of a system with an encoder, the user can calibrate the gap readout, which should be as described in Section 7.7.2, and the user can fill the chuck with monomer liquid if utilizing the system CLIPP (contact liquid photo-polymer) process capability.

M	GAP SET	-OO .O
	MOVE TO CONTACT POSITION	N2 Hard Contact
CONTACT D		CYCLE RUNN ING

Figure 7-14 Running Screen for Systems with Auto Level



Figure 7-14a Running Screen for Systems with Auto Level and Gap Display



Figure 7-15 Alarm List Screen

7.9.5 Manual Test Screen

The manual test screening provides for manual control of three items. These items are:

- Move the transport stage back and forth between the expose and the alignment position. As this is done, the display on the corresponding button on the LCD panel will change accordingly. The button is currently, in the figure shown, set to "move to expose position".
- Open and close the light source lamp shutter.
- Turn the mask vacuum on and off.
- In the case of a system with a CLIPP capability, an Unload button is available here to bring the chuck away from the mask after mask vacuum is disabled.



Figure 7-16 Manual Test Screen for Standard and Auto-Z



Figure 7-16a Manual Test Screen for Auto-Z with Gap Display

7.9.6 Process Setting Screen



Figure 7-17 Process Setting Screen Standard

The process setting screen is used for setting up your process. The process settings will be used to select the process mode and to select the exposure time.

- Pressing the exposure time button will cause a keypad screen to be displayed. Use this keypad display to enter the actual exposure time desired from 0.1 to 3276 seconds.
- Pressing the process mode button will toggle the process mode to front or back side alignment, IR back side alignment, Nano-Imprint (a nano-imprint tooling module is sold separately), or CLIPP (contact liquid photo-polymer

process, also sold separately, and requires encoder option to be installed). The speed that the chuck uses to approach the mask after the chuck has been filled during the CLIPP process can be adjusted between 71 and 710. This option is useful for eliminating bubbles that form between the monomer and the mask.

- The exposure can also be performed multiple times on a single substrate without releveling the substrate to the mask by setting the number of cycles and the off time, which will close the shutter in between cycles.
- Pressing the additional setting button will bring up the additional setting screen





7.9.7 Additional Settings Screen

On standard systems the additional setting screen allows you to set the date, time, and backlight display settings. Alarm functions are not currently supported.



Figure 7-18 Additional Setting Screen Standard

On systems with auto level and gap display the additional setting screen allows you to go to the Set Time & Date screenn and adjust the backlight display settings. Also the desired gap is set here, as well as a delay between process leveling and moving the chuck to the gap, which is useful if a longer time is

required to achieve mask/wafer planarization for a certain substrate. Alarm functions are not currently supported.

The MASK CHUCK SEPARATION TIME button controls the time allotted to the z-motion of the chuck during the unload process. After a wafer has been exposed, or when the UNLOAD button is pressed, the chuck will move down at a slow speed for the specified time before speeding up to complete the move down to its home position for wafer unloading. This is to allow the seal between the chuck and the mask to be gently broken so that the chuck and wafer are not temporarily held up against the mask while the axis continues to move down. Note: The mask chuck separation time can be set to any value between 2 and 20 seconds.

The WAFER SEPARATION DISTANCE button controls the distance that the chuck moves at a slow speed when separating from the mask to go to the alignment gap. This is to allow gentle separation of the wafer and mask so as not to pull photoresist off of the wafer and also to allow the chuck to maintain planarity with the mask. Thinner masks that deflect more during the leveling process will require larger separation distances as they will continue to remain in contact with the wafer longer as the chuck moves down and away from the mask. Note: The wafer separation distance can be set to any value between 119 and 499 microns.

The WAFER SEPARATION DELAY button controls the delay between motor steps while the wafer is moving down from the mask to go to the alignment gap. During this slow move (of a distance specified by the WAFER SEPARATION DISTANCE), the motor step size is constant but the step delay can be increased to effectively slow down the move. Note: The wafer separation delay time can be set to any value between 10 and 1000 milliseconds.



Figure 7-18a Additional Setting Screen for systems with Auto Level and Gap Display
7.9.8 Set Time & Date Screen

The set time & date screen (Figure 7-19) allows the user to set the time and date for systems with auto level and gap display.



Figure 7-19 Set Time & Date Screen for systems with Auto Level and Gap Display

7.9.9 Options Screen

The options screen (Figure 7-20) allows the user to tell the software whether or not an encoder is installed on the system. If the system is not equipped with an encoder, setting the system for encoder use will cause eratic system behavior and may damage system components.



Figure 7-20 Options Screen

SECTION 8: CALIBRATION OF ALIGNMENT OPTICS

The accuracy of backside alignment is highly dependent on the verticle calibration of the back side alignment optics. There are three points for each backside camera that need to be aligned. A special mask is provided with the system and should be used when performing the calibration procedure.



Figure 8.1 Adjustment point 1 & 2 (Right Side)....Left Side is identical



Figure 8.2 Adjustment point 3

8.1 PROCEDURE FOR OPTICS ALIGNMENT:

8.1.1 Tools Required:

- A mask with a large clear area to be able to see through to the OAI mirror mask tool.
- OAI mirror mask tool
- Allen wrenches

8.1.2 Purpose

The purpose of the alignment procedure is to align the focus axes of the bottom optics so they are perpendicular to the bottom surface of the mask. This will eliminate any misalignment caused by changing the focus position of the bottom optics from the mask to the bottom side of the wafer.

8.1.3 Location Of Adjustments

The leveling plate is the base plate on which the bottom optics XYZ assembly is mounted. It has 3 groups of screws, located at 3 of the 4 corners of the plate. Each group consists of a button head or socket head cap screw, and a socket set screw. We'll call them Set 1, Set 2, and Set 3.

Set 1 is located towards the front of the machine and away from the tooling.

Set 2 is nearest the tooling

Set 3 is farthest from the front of the machine.

8.1.4 Step by Step Procedure

Step 1 - Locate Set 1, and turn the socket set screw so that the base plate is spaced from the machine by about 3mm. This will provide enough room for adjusting the plane of the base plate using the other sets of screws. Lock down Set 1 by tightening the cap screw. Loosen the cap screws of Set 2 and Set 3 by several millimeters.

Step 2 - Install your clear mask into the system, and place the OAI mirror mask tool on top of the clear mask, facing down in a location that can be seen by the bottom optic.

Step 3 - Use the bottom optic to focus on the "real" alignment target at the center of the mirror mask tool. Align the alignment target with the cross hairs on the video monitor by using the X and Y micrometers on the bottom optic.

Now, turn the Z-micrometer on the bottom optic (or use the optic focus joystick if your system is so equipped) so that the focus position moves higher. Keep going until the "mirrored" alignment target comes into focus on the monitor. Using screw Set 2, move the "mirrored" alignment target towards the cross hair using the socket set screw. Continue moving it in that direction until it touches the outside edge of the monitor. Turn the optic z-micrometer so that the optic moves down to focus on the "real" alignment target.

Using the X and Y micrometers, align the "real" alignment target with the cross hairs.

Refocus on the "mirrored" alignment target. Check to see if it is still aligned with the cross hairs. If it isn't aligned, repeat step 3 until it is aligned.

Step 4 - Repeat steps 1, 2, and 3 for the other bottom optic.

SECTION 9: ALIGNMENT OF THE TOOLING MODULE

Note: The Alignment Optics must be calibrated before this adjustment. See the previous section for the procedure.



Figure 9.1 Tooling adjustment points

9.1 PROCEDURE FOR TOOLING LEVELING

9.1.1 Tools Required:

- A wafer with a target on which the alignment optics can be focused
- Allen wrenches

9.1.2 Purpose

The purpose of the alignment procedure is to align the Z-axis of the wafer chuck to the focus axis of the top alignment optics. This prevents shifting of the chuck in the X/Y axis relative to a fixed point on the alignment optics as the z-axis moves up and down. The procedure will ensure accurate alignment is maintained when moving the chuck from the align gap to the exposure height.

9.1.3 Location Of Adjustments

There are three adjustment points on the alignment tooling module that are used to ensure the wafer chuck is perpendicular to the alignment optics.

One point is in the middle at the front and the others are at the back on the sides.

The adjustments at each point consist of two screws. One screw raises and lowers the tooling at that point, and the other screw locks the setting down. (see figure 9-1)

9.1.4 Setup

- 1) Carefully remove the mask holder insert from the machine.
- 2) Place a wafer on the chuck, and if and auto-z system, move to gap.
- 3) Move the wafer chuck down several mm using the gap knob or the unload button if an auto-z system.
- Focus the bottom optic as best as possible on a wafer target.

9.1.5 Alignment

- **Step 1:** Align to the Crosshair on the Monitor.
- **Step 2** : Move the wafer chuck up several millimeters using the

Chuck Z-Axis adjustment or the Level Chuck button if an auto-z system.

- Step 3 : Focus the bottom optic on the wafer at the new chuck height.
- Step 4: The wafer target should not move in the X or Y axis while the previous step is being performed. If it does, adjust one of the 3 leveling points accordingly.
- **Step 5:** Move the chuck down several mm using the gap knob.
- **Step 6:** Repeat the procedure again until there is no longer a shift in the wafer target as the wafer chuck moves up and down.

SECTION 10: SYSTEM INTERLOCKS

10.1 UV LIGHT SOURCE INTERLOCKS

There are 3 interlocks on the UV LIGHT SOURCE. One is for personal safety and the other two are for equipment safety.

WARNING!



The light emanating from the light source is a hazard to vision. **DO NOT LOOK INTO THE OUTPUT BEAM of the UV Lamp** or reflection of the beam. Permanent damage to the retina of the eye and subsequent blindness can result.



Prolonged exposure to diffused reflection from the output beam, illuminated surfaces in the beam, exposures of even a few seconds to the direct output beam or to the lamp itself, can cause ultraviolet skin burns or burns to the outer layers of the eye. Prolonged skin exposure can cause burns similar to severe sunburn.



WHEN IN THE VACINITY OF A LIGHT SOURCE WITH ITS COVER REMOVED, <u>ALWAYS WEAR UV FILTERED</u> <u>GLASSES</u> TO PROTECT EYES AND LIMIT EXPOSURE TIME TO UV RADIATION.

Dangerous voltage is present on the ends of the UV Lamp when the lamp is lighted or being started.

10.1.1 The Personal Safety Interlock

Removes power from the UV power supply. Pull the interlock out to perform maintenance functions that require the UV POWER SUPPLY to be turned on.



10.1.2 The Overheat System Interlock

Removes power from the UV power supply if the mirror is not in place at approximately a 45-degree angle and locked into position. The interlock is designed to prevent the UV lamp from burning the bottom of the UV LIGHT SOURCE.



Overheat Equipment Safety Interlock

Figure 10-2 Overheat System Safety Interlock

10.1.3 The Air-flow System Safety Interlock

For UV Light Sources without an exhaust fan, the air-flow interlock removes power from the UV power supply if insufficient exhaust airflow is detected.



Exhaust Air-flow Equipment Safety Interlock

Figure 10-3. Airflow Equipment Safety Interlock

SECTION 11: HAZARDOUS MATERIALS USED WITH THE SYSTEM

11.1 ISOPROPYL ALCOHOL

Isopropyl alcohol is used to clean parts during maintenance activities. Isopropyl alcohol and the wipes used with the isopropyl alcohol are considered hazardous waste. As hazardous waste the isopropyl alcohol and the wipes should not be thrown into the garbage or flushed down the sewer. Instead, the wipes that are soaked in isopropyl alcohol should be placed in a chemical waste container and sent to a RCRA approved incinerator or to a RCRA approved waste facility. Check the local and state disposal regulations because some local and state regulations differ from federal disposal regulations.

Isopropyl alcohol is a clear, colorless, flammable liquid with an odor of rubbing alcohol. Relatively low toxicity by all exposure routes. Inhalation of vapor can cause eye and respiratory tract irritation. Exposure to extremely high concentrations (>1000ppm) can cause intoxication, dizziness, headache, anesthesia and coma. Avoid skin and eye contact. Use solvent resistant gloves, and safety glasses when using small quantities (e.g., squirt bottle amounts). Keep away from ignition sources, such as flame, spark, and heat. Both ACGIH TLV and OSHA PEL values are 200ppm. ACGIH also cites the STEL as 500ppm.

• The chemical is used to clean the UV lamp if fingerprints or oil are on the surface. The amount used is less than 10ml.

• The chemical is used to clean the UV lamp housing as needed. The amount is less than 10ml.

11.2 MERCURY

Mercury is contained in the mercury UV lamps and the mercury-xenon UV lamps that are used in the light source. Mercury is a regulated solid waste that should not be thrown in to the garbage but should be recycled according to local, state, or federal laws.

OAI recycles the mercury by sending the old UV lamps to Advance Radiation Corporation (408-727-9200) or to North State Environmental (650-588-2839). The used UV lamps are considered "Hazardous Waste" and do require a manifest recorded through the California Department of Toxic Substance Control or similar state agency outside of California, <u>but only for quantities in excess of 10 pounds of waste mercury or 24 lamps</u>. Otherwise, no special paperwork is required for shipment of used lamps. It is suggested that used or damaged lamps be double wrapped in a Ziplock bag then packaged in a corrugated box. Also broken mercury lamps and mercury contaminated wipes should be double wrapped in a Ziplock bag then packaged in a corrugated box and shipped to the same location as the lamps.

The UV lamps will have to be replaced about every 1000 hours. The weight of the mercury in each of the different sizes of lamps is shown below.

Lamp Wattage	Weight of Mercury in Ounces
200	0.0002
350	0.0002
500	0.00035
1000	0.00189
2000	0.00315

SECTION 12: DRAWINGS / SCHEMATICS

Drawing Description	Drawing #	<u>Rev</u>	<u>Pgs</u>
SCHEM ELEC SYS MAIN CFG 120V MDL 800MBA SCHEM ELEC SYS MAIN CFG 220V MDL 800MBA	0420-127-01* 0420-127-02*	F	2 2
SCHEM ELEC SYS MAIN MTR-Z 120V MDL800MBA	0420-127-07*	D	2
SCHEM SYSTEM ELEC MTR Z 240V MDL800MBA	0420-127-08*	D	2
SCHEM PNEU PNL MDL 800MBA	0420-128-01	F	1
DIAG INCON 2 TOP&BOT CAMR 800MBA	0420-129-01*	D	1
DIAG INCON 2 TOP CAMR 800MBA	0420-129-03*	В	1
DIAG WIRING IR LAMP OPTION MDL 800MBA	0420-133-01*	В	1
SCHEM Z-FOCUS MTRZD BACKSIDE MDL800	0420-134-01*	D	1

* = Depends on System Type Purchased























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Α	9025	ENGINEER RELEASE PER EC	:0	EP	EP	2/14/05	
В	9182	ADD AUTO Z SECTION		EP	EP	10/2/05	
С	9348	ADD SUPPLY CDA REG, SYSTEM CD	A 100 PSI & NITROG 30 PSI	VSP	VSP	4/12/06	
D	9442	CHG CONT VLV>BRK VLV, UPDT AU	ITO-Z EXHAUST CONN AREA	SP	EP	8/29/06	ł
E	10060	CHG LS TRANSIT PLUMBING		EP	EP	4/24/08	
F	10210	ADD LEVELING BALL NITROGEN PUR	IGE	EP	EP	12/5/08	

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A	9619	INTIAL RELEASE	MZ	мм	03/05/07
B	9634	ADD WIRE COLOR & CHG WIRING	MZ	мм	03/22/07
C	10076	CORRECTED VIRE COLORS	MM	мм	05/08/08
D	10136	Correct Viring For Pots	ММ	I _{мм}	07/29/08



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